Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/987,118	NOMURA ET AL.
Examiner	Art Unit
Thuy N. Pardo	2165

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SEARCHED						
Class	Subclass	Date	Examiner			
707	101	6/25/06	TP			
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702	185	V	$ \bigvee$			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
707	101	6/23/06	TP		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST IEEE	6/23/06	TP		